## Notice of References Cited Application/Control No. 10/765,783 Examiner Christopher B. Shin Applicant(s)/Patent Under Reexamination MARX ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,404,458	04-1995	Zetts, John M.	710/73
*	В	US-5,875,311	02-1999	Bertram et al.	710/305
*	С	US-6,753,853	06-2004	Dotson, Gary Dan	345/173
*	D	US-5,801,340	09-1998	Peter, Walter H.	178/20.04
*	Е	US-5,650,597	07-1997	Redmayne, Derek V.	178/18.06
*	F	US-4,581,483	04-1986	Ralston, Paul W.	178/20.01
*	G	US-2006/0022959	02-2006	Geaghan, Bernard O.	345/173
*	Ι	US-2002/0036621	03-2002	Liu et al.	345/173
*	-	US-4,816,698	03-1989	Hook, Glen C.	307/116
	J	US-	-		
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q	11111				
	R					
	S					
	Т				2	

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.